

**Search Notes**

Application/Control No.

10/748,053

Examiner

Djenane M. Bayard

Applicant(s)/Patent under  
Reexamination

HAMASAKI ET AL.

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	201	1/3/2008	DB
709	203	1/3/2008	DB
455	414	1/3/2008	db

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	1/3/2008	DB
Double Patenting search	1/3/2008	DB